<u>AMP</u>

Product Specification



BOARD-TO-BOARD COAXIAL CONNECTOR

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	DR : A.Mariotti	DATE: 07DEC06	APVD : D. Bozzer	DATE: 07DEC06
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Template 6301CT0002.C



1. SCOPE

1.1 Introduction

This specification covers performance, test and quality requirements for the BOARD-TO-BOARD COAXIAL CONNECTOR. This coaxial connector is designed to handle severe mechanical misalignment between two printed circuit boards and is a surface mount device (SMD).

A single connector achieves the connection as the top board acts like the counterpart with its dedicated "target" layout.

Permitted radial misalignment is 0.8 mm; permitted axial misalignment is ±1.0 mm from nominal stack height.

1.2 Qualification

When tests are performed on the subject product line, procedures specified in this Product Specification shall be used. All inspections shall be performed using applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, the latest edition of the document applies. In the event of conflict between requirements in this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements in this specification and referenced documents, this specification shall take precedence.

2.1 Tyco Electronics Documents

619127: Drawing for connector with nominal PCB distance 14 mm
 619134: Drawing for connector with nominal PCB distance 10 mm
 619135: Drawing for connector with nominal PCB distance 6.65 mm

501-90021: Qualification Test Report501-90024: Measurement Report

2.2 Commercial Standards

• EIA-364: Electrical Connector/Socket Test Procedures Including Environmental Classifications

IEC 60512: Electromechanical Components For Electronic Equipment; Basic Testing. Procedures and Measuring Methods Part 1: General

• IEC 60068: Basic Environmental Testing Procedures For Electric Components And Electronic Equipment

3. REQUIREMENTS

3.1 Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

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3.2 Materials

Materials used in the construction of this product shall be as specified on the applicable product drawing.

3.3 Ratings

Voltage: 125 volts AC

Current: Signal application only
 Temperature: -40°C to +125°C

Characteristic Impedance: 50 ohms
Frequency Range: Up to 6 GHz

3.4 Characteristic Values

• Shielding Effectiveness: -60 dB max

Parallel Stacking Height:

For PN 619127-1: 14 mm (nominal) For PN 619134-1: 10 mm (nominal) For PN 619135-1: 6.65 mm (nominal)

Radial Misalignment: ±0.8 mm max

• Axial Misalignment:

For PN 619127-1 : ±1.0 mm max
For PN 619134-1 : ±1.0 mm max
For PN 619135-1 : ±0.4 mm max
Angle between Boards: ±2° max

3.5 Performance and Test Description

The product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions per EIA-364.

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3.6 Test Requirements and Procedures Summary

Ref.	f. Test Description		Performance, Requirements	Procedure			
1.01.	Test Description		VISUAL	rioccurc			
C1	Initial examination of pro	oduct.	Meets requirements of product and customer drawings.	IEC 60512-2 test 1a. Magnification 5x. Visual, dimensional and functional. Inspection per product and customer drawings.			
C2	Final examination of pro	duct.	Meets visual requirements.	IEC 60512-2 test 1a. Magnification 5x. Visual inspection.			
			ELECTRICAL				
C3	Contact resistance.	Ou 10 Ce 20 With tin Ou 20 Ce Ce	old-plated target board: uter conductor: umilliohms maximum. enter conductor: umilliohms maximum. en-plated target board: uter conductor: umilliohms maximum. enter conductor: umilliohms maximum. enter conductor: umilliohms maximum.	IEC 60512-2-2a. Subject specimens to 100 milliamperes maximum and 20 millivolts maximum open circuit voltage. Measure with target board at maximum stack height. See Figure 2.			
C4	VSWR 6.65mm 10mm 14mm	<1.2 u	o to 2.2 GHz <1.3 up to 3 GHz o to 2.2 GHz <1.3 up to 3 GHz o to 2.2 GHz <1.3 up to 3 GHz	Measure return loss up to 3'000 MHz at nominal and maximum misaligned positions, radially and axially. See Figure 3.			
C5	Insertion loss. 6.65mm 10mm 14mm	<0.2 dl <0.2 dl	3 up to 2.2 GHz < 0.25 dB up to 3 GHz 3 up to 2.2 GHz < 0.25 dB up to 3 GHz 3 up to 2.2 GHz < 0.25 dB up to 3 GHz	Measure insertion loss up to 3'000 MHz at nominal and maximum misaligned positions, radially and axially. See Figure 3.			
C6	Shielding effectiveness.	-60 dB	maximum for f ≤ 2'500 MHz	Absorbing Clamp Method in IEC 60096-1 Amendment 2.			

Figure 1 (cont)

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Ref.	Test Description	Performance, Requirements	Procedure				
MECHANICAL							
C10	Vibration, sinus.	No discontinuities of	IEC 60512-4-6d.				
010	Vibration, sinus.	1 microsecond or longer duration.	Cycles: 10Hz-2000Hz-10Hz (1 cycle).				
		See Note.	10-58Hz: Const. amplitude of 0.75 mm,				
			58-2000Hz: Const. acceleration of 100				
			m/s ² . Sweep rate: 1 octave / minute.				
			Duration: 2 hours in each of 3 mutually				
			perpendicular directions.				
C11	Vibration, sinus.	See Note.	IEC 60512-4-6d.				
			Cycles: 10Hz-500Hz-10Hz (1 cycle).				
			10-58Hz: Const. amplitude of 1.5 mm, 58-500Hz: Const. acceleration of 200				
			lm/s ² .				
			Sweep rate: 1 octave / minute.				
			Duration: 2 hours in each of 3 mutually				
0.10			perpendicular directions.				
C12	Mating force.	Outer conductor: 2.5 to 10.0 N	Measure at maximum and minimum stack heights.				
		2.5 to 10.0 N	Stack Heights.				
		Center conductor:					
		0.8 to 4.0 N					
ENVIRONMENTAL							
C13	Rapid change of temperature.	See Note.	IEC 60512-6-11d.				
	Jan 19 Grand Production		Subject specimens to 10 cycles				
			between –40 and 105°C.				
045	T	lo Nut	Exposure time: 30 minutes				
C15	Temperature life.	See Note.	IEC 60512-6-11i. Subject mated specimens to 125°C for				
			1000 hours.				
C16	Mixed flowing gas.	See Note.	IEC 60068-2-60,				
	(SO ₂ /H ₂ S/Cl ₂ /NO ₂)		Test Ke,				
			Method 4.				
			Subject mated specimens for 10 days.				

Figure 1 (end)

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NOTE

Shall meet visual requirements, show no physical damage, and meet requirements of additional tests as specified in the Product Qualification and Requalification Test Sequence shown in Figure 6.

3.7 Additional Test and Measuring Details

Contact Resistance 3.7.1





Center Conductor

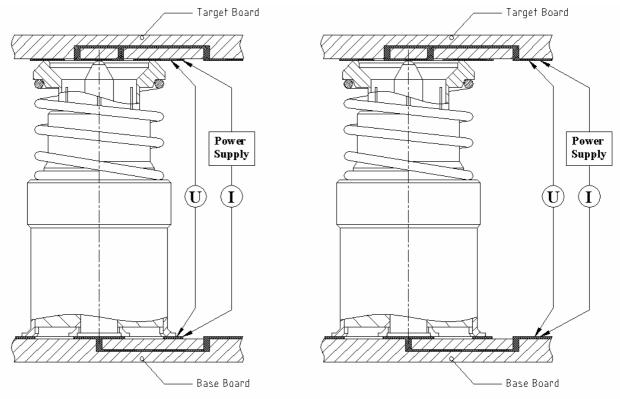


Figure 2

3.7.2 Return Loss and Insertion Loss

Calibration method:

- Actual frequency range on Network Analyser: 45 to 20.5 GHz
- Power: 10 dBm
- Number of measurement points: 401

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- Calibration planes: A, B.
- Full 2 port calibration : open, short, load, thru, (isolation).

Measurement method:

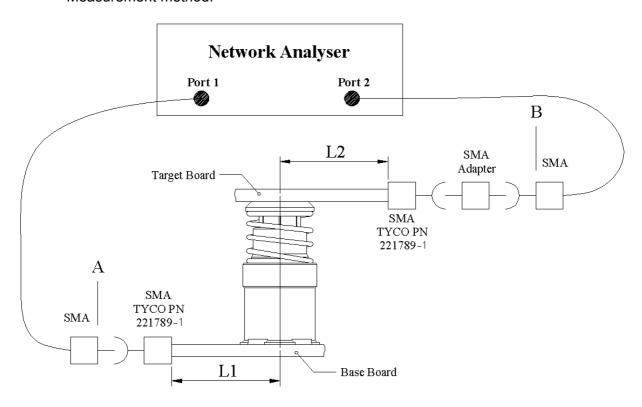


Figure 3

- Return loss: Measurement without gating.
- Insertion loss:
 Subtract 50 ohms line of reference board as shown in Figure 4 to isolate the share of the device under test.

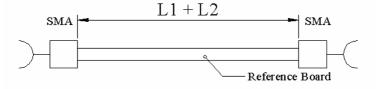


Figure 4

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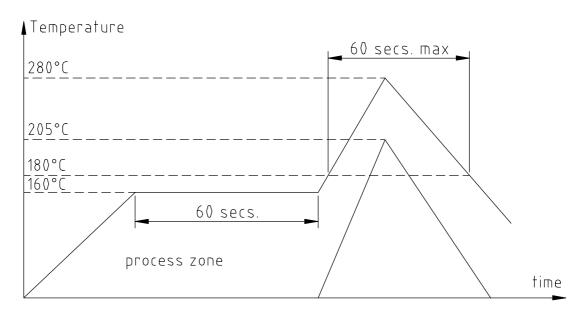
3.7.3 Resistance to Soldering Heat

This connector is suitable for reflow soldering onto a PCB within the limits of the following typical oven temperature profile in conjunction with lead free solder paste.

Temperature profile:

The process parameters are described by a profile of the temperature in the IR oven. The standard profile is:

- pre-heat up at 160°C maximum
- soak zone of 1 min maximum (at 160°C)
- heat up for reflow zone to minimum 205°C (coldest point)
- maximum time above melting temperature 60 seconds



Oven temperature profile

Figure 5

The soldering cycle should be repeated twice, i.e. first soldered and second time shall stand for another time through the oven.

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3.8 Product Qualification and Requalification Test Sequence

	TEST-GROUP (c)								
Test or Examination	Ref.	1a*	1b*	2a*	2b*	3a*	3b*	4	5
		TEST SEQUENCE (d)							
Initial examination of product	C1	1	1	1	1	1	1	1	1
Contact resistance	C3	2,6	2,6	3,6	3,6	2,4	2,4		
Return loss	C4							2	
Insertion loss	C5							3	
Shielding effectiveness	C6								2
Vibration, sinus (10g)	C10	5	5						
Vibration, sinus (20g)	C11	4	4						
Mating force	C12			2,5	2,5				
Rapid change of temperature	C13	3	3						
Temperature life	C15			4	4				
Mixed flowing gas	C16					3	3		
Final examination of product	C2	7	7	7	7	5	5		

NOTES

- a* With tin-plated (SnPb) target board
- b* With gold-plated (Au) target board
- (c) See paragraph 4.1.A.
- (d) Numbers indicate sequence in which tests are performed.

Figure 6

All test-groups are performed with specimens soldered on PCB's.

Stack height (PCB setting):

Test-group 1: Max

Test-groups 2 & 3: Nominal during environmental test,

Max for contact resistance measurements

Test-group 4: Nominal, Min, and Max

Test-group 5: Nominal

4. QUALIFICATION TEST RESULTS

All requirements were met. Refer to Test Report 501-90021 and Measurement Report 500-90024 for detailed results.

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5. QUALITY ASSURANCE PROVISIONS

5.1 Qualification Testing

A. Specimen Selection

Specimen shall be prepared in accordance with applicable Instruction Sheets and shall be selected at random from current production.

All test groups shall each consist of a minimum of 10 specimens P/N 619127-1 except test-group 4 for which a minimum of 5 specimens is required, and test-group 5 for which a minimum of 2 specimens is required.

B. Test Sequence

Qualification inspection shall be verified by testing specimens as specified in Figure 6.

5.2 Requalification Testing

If changes significantly affecting form, fit or function are made to product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of original testing sequence as determined by development/product, quality and reliability engineering.

5.3 Acceptance

Acceptance is based on verification that product meets requirements of Figure 1. Failures attributed to equipment, test setup, customer supplied components or operator deficiencies shall not disqualify the product. If product failure occurs, corrective action shall be taken and samples resubmitted for qualification. Testing to confirm corrective action is required before resubmittal.

5.4 Quality Conformance Inspection

The applicable quality inspection plan shall specify the sampling acceptable quality level to be used.

Dimensional and functional requirements shall be in accordance with applicable product drawing and this specification.

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